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Bus-Powered M Series Multifunction DAQ for USB - 16-Bit, up to 400 kS/s, up to 32 Analog Inputs, Isolation





Up to 32 analog inputs at 16 bits, up to 400 kS/s (250 kS/s scanning) Up to 2 analog outputs at 16 bits Up to 32 TTL/CMOS digital I/O lines Two 32-bit, 80 MHz counter/timers NI-PGIA 2 and NI-MCal calibration technology for improved measurement accuracy NI signal streaming for 4 high-speed data streams on USB Bus-powered design Available with CAT I isolation

Overview

With recent bandwidth improvements and new innovations from National Instruments, USB has evolved into a core bus of choice for measurement and automation applications. NI M Series devices for USB deliver high-performance data acquisition in an easy-to-use and portable form factor through USB ports on laptop computers and other portable computing platforms. National Instruments designed the new and innovative patent-pending NI signal streaming technology that enables sustained bidirectional high-speed data streams on USB. The new technology, combined with advanced external synchronization and isolation, helps engineers and scientists achieve high-performance applications on USB.

NI M Series bus-powered multifunction data acquisition (DAQ) devices for USB are optimized for superior accuracy in a small form factor. They provide an onboard NI-PGIA 2 amplifier designed for fast settling times at high scanning rates, ensuring 16-bit accuracy even when measuring all available channels at maximum speed.

All bus-powered devices have a minimum of 16 analog inputs, digital triggering, and two counter/timers. USB M Series devices are ideal for test, control, and design applications including portable data logging, field monitoring, embedded OEM, in-vehicle data acquisition and academic.

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Requirements and Compatibility									
OS Information	Driver Information	Software Compatibility							
Windows 2000/XP	NI-DAQmx	ANSI C/C++							
Windows Vista x64/x86	NI-DAQmx Base	LabVIEW							
Linux®		LabVIEW SignalExpress							
Mac OS X		LabWindows/CVI							
		Measurement Studio							

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Comparison Tables

Family	Connector	Analog Inputs	Resolution (bits)	Max Rate (kS/s)	Analog Outputs	Resolution (bits)	Max Rate (kS/s)	Digital I/O	Isolation
USB-6210	Screw	16	16	250	-	-	-	4 DI/4 DO	-
USB-6211	Screw	16	16	250	2	16	250	4 DI/4 DO	-
USB-6212	Screw/68-pin SCSI	16	16	400	2	16	250	24 or 32 DIO	-

Family	Connector	Analog Inputs	Resolution (bits)	Max Rate (kS/s)	Analog Outputs	Resolution (bits)	Max Rate (kS/s)	Digital I/O	Isolation
USB-6215	Screw	16	16	250	2	16	250	4 DI/4 DO	60 V, CAT I
USB-6216	Screw/68-pin SCSI	16	16	400	2	16	250	24 or 32 DIO	60 V, CAT I
USB-6218	Screw	32	16	250	2	16	250	8 DI/8 DO	60 V, CAT I

Application and Technology

NI Signal Streaming

To optimize the use of the Universal Serial Bus (USB) and deliver high-performance data acquisition, National Instruments created several key technologies to push the limits of USB throughput and latency. NI signal streaming combines three innovative hardware- and software-level design elements to enable sustained high-speed and bidirectional data streams over USB. For more information, visit **ni.com/usb**.

USB M Series for Test

You can use USB M Series multifunction DAQ devices for low-cost test or to complement existing test systems that need additional measurement channels. For higherchannel-count signal conditioning on USB, consider the NI CompactDAQ or SCXI platforms.

USB M Series for Design

For design applications, you can use a wide range of I/O – from 16 differential analog inputs to 32 digital lines – to measure and verify prototype designs. USB M Series devices and NI LabVIEW SignalExpress interactive measurement software deliver benchtop measurements to the PC. With LabVIEW SignalExpress, you can quickly create design verification tests. You can convert your tested and verified LabVIEW SignalExpress projects to LabVIEW applications for immediate M Series DAQ use, and bridge the gap between test, control, and design applications.

USB M Series for OEM

Shorten your time to market by integrating world-class National Instruments OEM measurement products in your design. Board-only versions of USB M Series DAQ devices for OEM applications feature competitive quantity pricing and software customization. The NI OEM Elite Program offers free 30-day trial kits for qualified customers. Visit **ni.com/oem** for more information.

Recommended Driver Software

National Instruments measurement services software, built around NI-DAQmx driver software, includes intuitive application programming interfaces, configuration tools, I/O assistants, and other tools designed to reduce system setup, configuration, and development time. National Instruments recommends using the latest version of NI-DAQmx driver software for application development in NI LabVIEW, LabVIEW SignalExpress, LabWindowsTM/CVI, and Measurement Studio software. To obtain the latest version of NI-DAQmx, visit **ni.com/support/daq/versions**. NI measurement services software speeds up your development with features including the following:

A guide to create fast and accurate measurements with no programming using the DAQ Assistant

Automatic code generation to create your application in LabVIEW; LabWindows/CVI; LabVIEW SignalExpress; and C#, Visual Studio .NET, ANSI C/C++, or Visual Basic using Measurement Studio

Multithreaded streaming technology for 1,000 times performance improvements

Automatic timing, triggering, and synchronization routing to make advanced applications easy

More than 3,000 free software downloads available at **ni.com/zone** to jump-start your project

Software configuration of all digital I/O features without hardware switches/jumpers

Single programming interface for analog input, analog output, digital I/O, and counters on hundreds of multifunction DAQ hardware devices

M Series devices are compatible with the following versions (or later) of NI application software – LabVIEW, LabWindows/CVI, or Measurement Studio versions 7.x; and LabVIEW SignalExpress 2.x.

Recommended Accessories

(Mass-Terminal Versions)

Signal conditioning is required for sensor measurements or voltage inputs greater than 10 V. NI SCC products, which are designed to increase the performance and reliability of your data acquisition system, are up to 10 times more accurate than using terminal blocks alone. For more information, visit **ni.com/sigcon**.

Ordering Information

For a complete list of accessories, visit the product page on ni.com.

Products	Part Number	Recommended Accessories	Part Number
NI USB-6212			
NI USB-6212	780107-01	No accessories required.	
NI USB-6216			
NI USB-6216	780108-01	No accessories required.	

NI USB-6212			
NI USB-6212 Mass Terminal Each NI USB-6212 Mass Terminal requires: 1 Cable, 1 Connector Block	780169-01	Cable: Shielded - SH68-68-EPM Cable (1m)	199006-01
		Connector Block: Screw Terminals - SCB-68 **Also available: BNC Termination	776844-01
NI USB-6216			
NI USB-6216 Mass Terminal Each NI USB-6216 Mass Terminal requires: 1 Cable, 1 Connector Block	780170-01	Cable: Shielded - SH68-68-EPM Cable (1m)	199006-01
		Connector Block: Screw Terminals - SCB-68 **Also available: BNC Termination	776844-01
NI USB-6218			
NI USB-6218 (Windows)	779678-01	No accessories required.	
NI USB-6218 (Mac OS X and Linux)	780106-01	No accessories required.	
NI USB-6215			
NI USB-6215	779677-01	No accessories required.	
NI USB-6215 (Mac OS X and Linux)	780105-01	No accessories required.	
NI USB-6210			
NI USB-6210 (Windows)	779675-01	No accessories required.	
NI USB-6210 (Mac OS X and Linux)	780103-01	No accessories required.	
NI USB-6211			
NI USB-6211 (Windows)	779676-01	No accessories required.	
NI USB-6211 (Mac OS X and Linux)	780104-01	No accessories required.	

Software Recommendations

NI LabVIEW SignalExpress for Windows



NI LabWindows™/CVI pour Windows



Configuration rapide des projets sans aucune programmation Contrôle de 400 instruments autonomes et

sur PC Enregistrement de données à partir de plus de 250 matériels d'acquisition de données Réalisation de traitements de signaux, d'analyses et E/S sur fichier de base Évolution d'applications avec la génération

automatique de code LabVIEW Création de rapports personnalisés ou exportation facile des données vers LabVIEW, DIAdem ou Microsoft Excel

Graphes et graphiques 2D temps réel

Compatibilité matérielle complète avec les

matériels IVI, VISA, DAQ, GPIB et série

Outils d'analyse pour la manipulation de tableaux. les statistiques de traitement des

Communication simplifiée entre plates-formes

Outils Measurement Studio .NET (inclus avec LabWindows/CVI Édition complète

LabWindows est utilisé sous licence Microsoft

signaux et l'interpolation linéaire

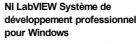
avec les variables réseaux

avancés, avec support de Windows

Vista/XP/2000

uniquement)

Corporation





NI Measurement Studio Édition professionnelles



Environnement de développement graphique facile à utiliser

Intégration rigoureuse d'une vaste gamme de matériels de mesure

Développement rapide de l'interface utilisateur permettant d'afficher des données en direct

Fonctionnalités étendues de traitement de signaux, d'analyse et de mathématiques

Intégration du contrôle de code source et de l'analyse statistique de complexité de code

Support de Windows 7/Vista/XP (32 bits) et de Windows 7/Vista (64 bits)

Support de Microsoft Visual Studio .NET 2005/2008/2010

Contrôles des formulaires Windows et Web personnalisables, pour la conception d'interface utilisateur d'applications de test et de mesure

Support de l'intégration matérielle par des bibliothèques d'acquisition de données et de contrôle d'instruments

Génération automatique de code avec l'acquisition de données, le contrôle d'instruments et les assistants de paramétrage

Communication entre plates-formes avec des variables réseaux

Bibliothèques d'analyse pour les opérations de matrice, la génération de signaux, le fenêtrage, les filtres et le traitement du signal

Support and Services

Calibration

NI measurement hardware is calibrated to ensure measurement accuracy and verify that the device meets its published specifications. NI offers a number of calibration services to help maintain the ongoing accuracy of your measurement hardware. These services allow you to be completely confident in your measurements, and help you maintain compliance

to standards like ISO 9001, ANSI/NCSL Z540-1 and ISO/IEC 17025. To learn more about NI calibration services or to locate a qualified service center near you, contact your local sales office or visit ni.com/calibration.

Technical Support

Get answers to your technical questions using the following National Instruments resources.

Support - Visit ni.com/support to access the NI KnowledgeBase, example programs, and tutorials or to contact our applications engineers who are located in NI sales offices around the world and speak the local language.

Discussion Forums - Visit forums.ni.com for a diverse set of discussion boards on topics you care about.

Online Community - Visit community.ni.com to find, contribute, or collaborate on customer-contributed technical content with users like you.

Repair

While you may never need your hardware repaired, NI understands that unexpected events may lead to necessary repairs. NI offers repair services performed by highly trained technicians who quickly return your device with the guarantee that it will perform to factory specifications. For more information, visit ni.com/repair.

Training and Certifications

The NI training and certification program delivers the fastest, most certain route to increased proficiency and productivity using NI software and hardware. Training builds the skills to more efficiently develop robust, maintainable applications, while certification validates your knowledge and ability.

Classroom training in cities worldwide - the most comprehensive hands-on training taught by engineers.

On-site training at your facility - an excellent option to train multiple employees at the same time.

Online instructor-led training - lower-cost, remote training if classroom or on-site courses are not possible.

Course kits - lowest-cost, self-paced training that you can use as reference guides.

Training memberships and training credits - to buy now and schedule training later.

Visit ni.com/training for more information.

Extended Warranty

NI offers options for extending the standard product warranty to meet the life-cycle requirements of your project. In addition, because NI understands that your requirements may change, the extended warranty is flexible in length and easily renewed. For more information, visit ni.com/warranty.

OEM

NI offers design-in consulting and product integration assistance if you need NI products for OEM applications. For information about special pricing and services for OEM customers, visit ni.com/oem.

Alliance

Our Professional Services Team is comprised of NI applications engineers, NI Consulting Services, and a worldwide National Instruments Alliance Partner program of more than 600 independent consultants and integrators. Services range from start-up assistance to turnkey system integration. Visit ni.com/alliance.

Detailed Specifications

View Detailed Specifications Table of Contents

Specifications listed below are typical at 25 °C unless otherwise noted. Refer to the NI USB-621x User Manual for more information about USB-621x devices.

Caution The input/output ports of this device are not protected for electromagnetic interference due to functional reasons. As a result, this device may experience reduced measurement accuracy or other temporary performance degradation when connected cables are routed in an environment with radiated or conducted radio frequency electromagnetic interference.

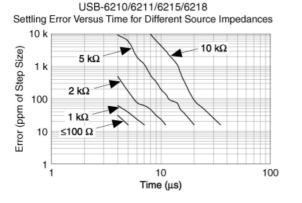
To ensure that this device functions within specifications in its operational electromagnetic environment and to limit radiated emissions, care should be taken in the selection, design, and installation of measurement probes and cables.

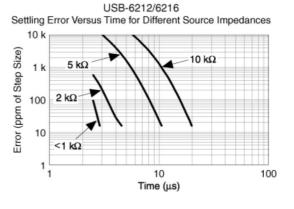
Analog Input

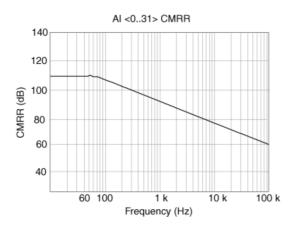
Number of channels	
USB-6210/6211/6212/6215/6216	8 differential or 16 single ended
USB-6218	16 differential or 32 single ended
ADC resolution	16 bits
DNL	No missing codes guaranteed
INL	Refer to the Al Absolute Accuracy Tables
Sampling rate	
Maximum	
USB-6210/6211/6215/6218	250 kS/s single channel, 250 kS/s multichannel (aggregate)
USB-6212/6216	400 kS/s single channel, 400 kS/s multichannel (aggregate)
Minimum	0 S/s
Timing accuracy	50 ppm of sample rate
Timing resolution	50 ns

Input coupling	DC
Input range	±10 V, ±5 V, ±1 V, ±0.2 V
Maximum working voltage for analog inputs (signal + common mode)	±10.4 V of AI GND
CMRR (DC to 60 Hz)	100 dB
Input impedance	
Device on	
AI+ to AI GND	>10 G Ω in parallel with 100 pF
Al- to Al GND	>10 G Ω in parallel with 100 pF
Device off	
Al+ to Al GND	1200 Ω
AI- to AI GND	1200 Ω
Input bias current	±100 pA
Crosstalk (at 100 kHz)	
Adjacent channels	-75 dB
Non-adjacent channels	-90 dB
Small signal bandwidth (-3 dB)	
USB-6210/6211/6215/6218	450 kHz
USB-6212/6216	1.5 MHz
Input FIFO size	4,095 samples
Scan list memory	4,095 entries
Data transfers	USB Signal Stream, programmed I/O
Overvoltage protection (AI <031>, AI SENSE)	
Device on	±30 V for up to two Al pins
Device off	±20 V for up to two Al pins
Input current during overvoltage condition	±20 mA max/Al pin
Settling Time for Multichannel Measurements	
Accuracy, full scale step, all ranges	
USB-6210/6211/6215/6218	
±90 ppm of step (±6 LSB)	4 μs convert interval
±30 ppm of step (±2 LSB)	5 μs convert interval
±15 ppm of step (±1 LSB)	7 µs convert interval
USB-6212/6216	
±90 ppm of step (±6 LSB)	2.5 µs convert interval
±30 ppm of step (±2 LSB)	3.5 µs convert interval
±15 ppm of step (±1 LSB)	5.5 µs convert interval
Typical Performance Graphs	

Typical Performance Graphs







Analog Output

Back to Detailed Specs

Number of channels	
USB-6210	0
USB-6211/6212/6215/6216/6218	2
DAC resolution	16 bits
DNL	±1 LSB
Monotonicity	16 bit guaranteed
Maximum update rate	
1 channel	250 kS/s
2 channels	250 kS/s per channel
Timing accuracy	50 ppm of sample rate
Timing resolution	50 ns
Output range	±10 V
Output coupling	DC
Output impedance	0.2 Ω
Output current drive	±2 mA
Overdrive protection	±30 V
Overdrive current	2.4 mA
Power-on state	±20 mV
Power-on glitch	±1 V for 200 ms
Output FIFO size	8,191 samples shared among channels used
Data transfers	USB Signal Stream, programmed I/O
AO waveform modes: Non-periodic waveform Periodic waveform regeneration mode from onboard FIFO Periodic waveform regeneration from host buffer including dynamic update	
Settling time, full scale step 15 ppm (1 LSB)	32 µs
Slew rate	5 V/µs
Glitch energy	
Magnitude	100 mV
Duration	2.6 µs
Calibration (AI and AO)	Back to Detailed Specs
Recommended warm-up time	15 minutes
Calibration interval	1 year
Al Absolute Accuracy Table (USB-6210/6211/6215/6218)	

Residual Gain Gain Tempco Reference Residual Offset Offset Tempco

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Nominal Range

Sensitivity²

Absolute

Random

INL Error

Positive Full Scale	Negative Full Scale	Error (ppm of Reading)	(ppm/°C)	Tempco	Error (ppm of Range)	(ppm of Range/°C)	(ppm of Range)	Noise, σ (μVrms)	Accuracy at Full Scale ¹ (µV)	(µV)
10	-10	75	7.3	5	20	34	76	229	2,690	91.6
5	-5	85	7.3	5	20	36	76	118	1,410	47.2
1	-1	95	7.3	5	25	49	76	26	310	10.4
0.2	- 0.2	135	7.3	5	40	116	76	12	88	4.8
AbsoluteAccuracy	• •	, ,	, ,		tainty alCal) + Reference	Tempco · (Temp(hangeFroml ast	ExternalCal)		
					ernalCal) + INL_Er			Externation		
NoiseUncertai	nty = $\frac{\text{Randon}}{2}$	mNoise · 3 /100	For a cove	erage factor	of 3 σ and ave	raging 100 poi	nts.			
¹ Absolute accura	cy at full scale or	the analog inpu	t channels is de	termined usin	g the following ass	umptions:				
TempChangeFror	mLastExternalCal	= 10 °C								
TempChangeFror	mLastInternalCal	= 1 °C								
number_of_readir	ngs = 100									
CoverageFactor =	-3σ									
For example, on t	ne 10 V range, th	e absolute accur	acy at full scale	is as follows:						
GainError = 75 pp	om + 7.3 ppm · 1 ·	+ 5 ppm · 10 Gai	nError = 132 pp	m						
OffsetError = 20 p	opm + 34 ppm · 1	+ 76 ppm Offset	Error = 130 ppm	I						
NoiseUncertai	$nty = \frac{229 \ \mu}{\sqrt{10}}$	<u>V · 3</u> No	iseUncertaint	y = 68.7 j	μV					
AbsoluteAccuracy	= 10 V · (GainEr	ror) + 10 V · (Off	setError) + Nois	eUncertainty	AbsoluteAccuracy =	= 2,690 μV				
² Sensitivity is the	smallest voltage	change that can	be detected. It i	s a function c	f noise.					
Accuracies listed	are valid for up to	one year from the	ne device extern	al calibration.						

	l Range	Residual Gain			Residual	Offset	INL Error	Random	Absolute	
Positive Full Scale	Negative Full Scale	Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Offset Error (ppm of Range)	Tempco (ppm of Range/°C)	(ppm of Range)	Noise, σ (μVrms)	Accuracy at Full Scale ¹ (μV)	Sensitivity (µV)
10	-10	75	7.3	5	20	34	76	295	2,710	118.0
5	-5	85	7.3	5	20	36	76	149	1,420	59.6
1	-1	95	7.3	5	25	49	76	32	310	12.8
0.2	- 0.2	135	7.3	5	40	116	76	13	89	5.2
	sidualAlOffsetErrinity = $\frac{\text{Rando}}{1}$			-	rnalCal) + INL_E		oints			
		$\sqrt{100}$								
Absolute accur	acy at full scale o	on the analog inp	ut channels is de	etermined using	the following ass	sumptions:				
TempChangeFro	mLastExternalCa	al = 10 °C								
[empChangeFro	mLastInternalCa	I = 1 °C								
number_of_read	ngs = 100									
CoverageFactor	= 3 σ									
or example, on	the 10 V range, t	he absolute accu	iracy at full scale	is as follows:						
GainError = 75 p	pm + 7.3 ppm · 1	+ 5 ppm · 10 Ga	ainError = 132 pp	om						
	ppm + 34 ppm · ′									
NoiseUncerta	$inty = \frac{295 \mu}{\sqrt{1}}$	$\frac{1V \cdot 3}{00}$ N	oiseUncertain	ty = 88.5 μ	lV					
			ffsetError) + Nois	eUncertainty A	bsoluteAccuracy	= 2,690 µV				
	y = 10 V · (GainE	(O)								
AbsoluteAccurac	y = 10 V · (GainE e smallest voltag	, (,	is a function of	noise.					
AbsoluteAccurac		e change that ca	n be detected. It		noise.					

Nomina	Nominal Range				Residual	Offset Tempco		Random	Absolute	_
Positive Full Scale	Negative Full Scale			Gain Tempco Reference Offset Error (ppm/°C) Tempco (ppm of Range)		(nnm of	INL Error (ppm of Range)	Noise	Accuracy at Full Scale ¹ (µV)	Sensitivity ² (µV)
10	-10	90	11	5	60	12	128	3,512	2,710	118.0
Accuracies listed a AbsoluteAccuracy GainError = Resid	cy at full scale numb re valid for up to on = OutputValue · (Ga dualGainError + Gai idualOffsetError + A	e year from the ainError) + Rar nTempco · (Te	e device externange · (OffsetErnange · (OffsetErnangeFrom	al calibration or) mLastInterna	ICal) + Referen	ceTempco · (Ter				

Digital I/O/PFI

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Static Characteristics	
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lumber of channels	
Digital input	
USB-6210/6211/6215	4 (PFI <03>/P0.<03>)
USB-6218	8 (PFI <03>/P0.<03>, PFI <811>/P0.<47>)
Digital output	
USB-6210/6211/6215	4 (PFI <47>/P1.<03>)
USB-6218	8 (PFI <47>/P1.<03>, PFI <1215>/P1.<47>)
Digital input or output	
USB-6212/6216 Screw Terminal	32 total, 16 (P0.<015>), 16 (PFI<07>/P1.<07>, PFI<815>/P2.<07>)
USB-6212/6216 Mass Termination/BNC	24 total, 8 (P0.<07>), 16 (PFI<07>/P1.<07>, PFI<815>/P2.<07>)
Ground reference	D GND
Pull-down resistor	
USB-6210/6211/6215/6218	47 kΩ ±1%
USB-6212/6216	50 kΩ typical, 20 kΩ minimum
nput voltage protection ¹	±20 V on up to 8 pins
PFI Functionality	
JSB-6210/6211/6215/6218	
PFI <03>, PFI <811>/Port 0	
Functionality	Static digital input, timing input
Debounce filter settings	125 ns, 6.425 $\mu s,$ 2.56 ms, disable; high and low transitions; selectable per input
PFI <47>, PFI <1215>/Port 1	
Functionality	Static digital output, timing output
Timing output sources	Many Al, AO, counter timing signals
JSB-6212/6216 PFI <015>	
Functionality	Static digital input, static digital output, timing input, timing output
Timing output sources	Many Al, AO, counter timing signals
Debounce filter settings	125 ns, 6.425 µs, 2.56 ms, disable; high and low transitions; selectable per input

Maximum Operation Conditions		
Level	Min	Мах
IOL output low current	_	16 mA
IOH output high current	—	-16 mA

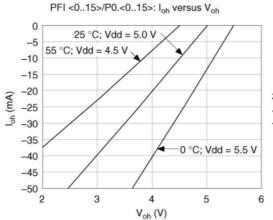
Digital Input Characteristics (USB-6210/6211/6215/6218)		
Level	Min	Мах
V _{IL} input low voltage	0 V	0.8 V
V _{IH} input high voltage	2 V	5.25 V

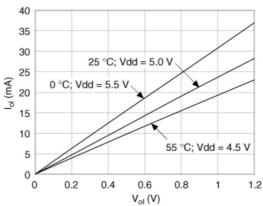
I∟ input low current (Vin = 0 V)	_	-10 μA
l _{IH} input high current (V _{in} = 5 V)	—	120 µA

Digital Input Characteristics (USB-6212/6216)		
Level	Min	Мах
V⊾ input low voltage	0 V	0.8 V
V _{IH} input high voltage	2.2 V	5.25 V
I _{IL} input low current (V _{in} = 0 V)	_	-10 μA
l⊮ input high current (Vin = 5 V)	_	250 µA
Positive-going threshold (VT+)	_	2.2 V
Negative-going threshold (VT-)	0.8 V	_
Delta VT hysteresis (VT+ - VT-)	0.2 V	_

Digital Output Characteristics (USB-6210/6211/6215/6218)			
Parameter	Voltage Level	Current Level	
Vol	0.6 V	6 mA	
N	2.7 V	-16 mA	
Vон	3.8 V	-6 mA	

Digital Output Characteristics (USB-6212/6216)





PFI <0..15>/P0.<0..15>: I_{ol} versus V_{ol}

General-Purpose Counter/Timers

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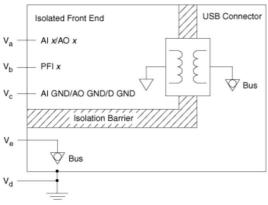
Number of counter/timers	2
Resolution	32 bits
Counter measurements	Edge counting, pulse, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	80 MHz, 20 MHz, 0.1 MHz
External base clock frequency	0 MHz to 20 MHz
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	
USB-6210/6211/6215/6218	PFI <03>, PFI <811>, many internal signals
USB-6212/6216	PFI <015>, many internal signals
FIFO	1,023 samples
Data transfers	USB Signal Stream, programmed I/O

Frequency Generator	Back to Detailed Specs
Number of channels	1
Base clocks	10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm
Output can be available on any output PFI terminal.	
External Digital Triggers	Back to Detailed Specs
Source	
USB-6210/6211/6215/6218	PFI <03>, PFI <811>
USB-6212/6216	PFI <015>
Polarity	Software-selectable for most signals
Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer functions	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Bus Interface	Back to Detailed Specs
USB	USB 2.0 Hi-Speed or Full-Speed ²
USB Signal Stream (USB)	4, can be used for analog input, analog output, counter/timer 0, counter/timer 1
Power Limits	Back to Detailed Specs
+5 V terminal as output ³	
Voltage	4.6 to 5.2 V
Current (internally limited)	50 mA max, shared with digital outputs
+5 V terminal as input ³	
Voltage	4.75 to 5.35 V
Current	350 mA max, self-resetting fus
Caution Do not exceed 16 mA per DIO pin.	
Protection	±10 V
Power Requirements	Back to Detailed Specs
Input voltage on USB-621x USB port	4.5 to 5.25 V in configured state
Maximum inrush current	500 mA
No load typical current	320 mA at 4.5 V
Maximum load	
Typical current	400 mA at 4.5 V
Suspend current	260 μA, typical
Physical Characteristics	Back to Detailed Specs
Enclosure dimensions (includes connectors)	
USB-621x Screw Terminal	16.9 × 9.4 × 3.1 cm (6.65 × 3.70 × 1.20 in.)
USB-621x Mass Termination	19.3 × 9.4 × 3.1 cm (7.61 × 3.68 × 1.20 in.)
USB-621x BNC	23.5 × 11.2 × 6.4 cm (9.25 × 4.40 × 2.50 in.)
Weight	
USB-621x Screw Terminal	206 g (7.2 oz)
USB-6212 Mass Termination	227 g (8.0 oz)
USB-6216 Mass Termination	231 g (8.1 oz)
USB-6212/6216/6218 BNC	950 g (33.5 oz)
USB-6210 OEM	73 g (2.5 oz)

USB-6212/6216/6218 OEM	76 g (2.6 oz)	
I/O connectors		
USB-6210/6211/6215	Two 16-position combicon	
USB-6212/6216/6218 Screw Terminal	Four 16-position combicon	
USB-6212/6216 Mass Termination	One 68-pin SCSI	
USB-6212/6216/6218 BNC	19 BNCs and 26 screw terminals	
USB connector	Series B receptacle	
Screw terminal wiring	16 to 28 AWG	
Torque for screw terminals	0.22-0.25 N · m (2.0 -2.2 lb · in.)	
Environmental	Back to I	Detailed Specs
Operating temperature	0 to 45 °C	
Storage temperature	-20 to 70 °C	
Humidity	10 to 90% RH, noncondensing	
Maximum altitude	2,000 m	
Pollution Degree (indoor use only)	2	
Maximum Working Voltage ⁴	Back to I	Detailed Specs
USB-6210/6211/6212 Rated Voltage		
Channel-to-earth ground	11 V, Measurement Category I	
Caution Do not use for measurements within Categories II, III, or IV.		
USB-6215/6216/6218 Rated Voltage		
Channel-to-earth ground ⁵		
Continuous	≤60 VDC, Measurement Category I ⁶	
Withstand	≤1000 Vrms, verified by a 5 s dielectric withstand test	
Analog channel to AI GND/AO GND (in the USB-6215/6216/6218 Maximum Working Voltage figure, Va - Vc)	≤11 V, Measurement Category I ⁶	
Digital channel to D GND (in the USB-6215/6216/6218 Maximum Working Voltage figure, V_{b} - $V_{\text{c}})$	≤5.25 V, Measurement Category I ⁶	

Caution This device is rated for Measurement Category I and the voltage across the isolation barrier is limited to no greater than 30 Vrms/60 VDC/42.4 V_{pk} continuous. Do *not* use for measurements within Categories II, III, or IV.

The USB-6215/6216/6218 Maximum Working Voltage figure illustrates the maximum working voltage specifications.



USB-6215/6216/6218 Maximum Working Voltage

Safety

Back to Detailed Specs

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

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IEC 61010-1, EN 61010-1
UL 61010-1, CSA 61010-1
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Note For UL and other safety certifications, refer to the product label or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

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This product is designed to meet the requirements of the following standards of EMC for electrical equipment for measurement, control, and laboratory use:

EN 61326 (IEC 61326): Class A emissions; Basic immunity EN 55011 (CISPR 11): Group 1, Class A emissions AS/NZS CISPR 11: Group 1, Class A emissions FCC 47 CFR Part 15B: Class A emissions

ICES-001: Class A emissions

Note For the standards applied to assess the EMC of this product, refer to the Online Product Certification section.

Note For EMC compliance, operate this product according to the documentation.

Note For EMC compliance, operate this device with shielded cables.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

2006/95/EC; Low-Voltage Directive (safety) 2004/108/EC; Electromagnetic Compatibility Directive (EMC)

Online Product Certification

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Environmental Management

National Instruments is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial not only to the environment but also to NI customers.

For additional environmental information, refer to the NI and the Environment Web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

Waste Electrical and Electronic Equipment (WEEE)

EU Customers At the end of their life cycle, all products must be sent to a WEEE recycling center. For more information about WEEE recycling centers and National Instruments WEEE initiatives, visit ni.com/environment/weee.htm

电子信息产品污染控制管理办法 (中国 RoHS)

中国客户 National Instruments 符合中国电子信息产品中限制使用某些有害物质指令 (RoHS)。 00 关于 National Instruments 中国 RoHS 合规性信息,请登录 ni.com/environment/rohs_china。 (For information about China RoHS compliance, go to ni.com/environment/rohs_china,)

¹ Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

² If you are using a USB M Series device in Full-Speed mode, device performance will be lower and you will not be able to achieve maximum sampling/update rates.

³ USB-621x Screw Terminal/BNC devices have a self-resetting fuse that opens when current exceeds this specification. USB-621x Mass Termination devices have a user-replaceable socketed fuse that opens when current exceeds this specification. Refer to the NI USB-621x User Manual for information about fuse replacement. ⁴ Maximum working voltage refers to the signal voltage plus the common-mode voltage.

 5 In the USB-6215/6216/6218 Maximum Working Voltage figure, $|V_a-V_d|,\,|V_b-V_d|,$ and $|V_c-V_d|.$

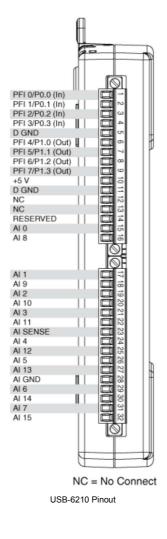
⁶ Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated low-voltage sources, and electronics. ⁷ In the USB-6215/6216/6218 Maximum Working Voltage figure, $|V_a - V_e|$, $|V_b - V_e|$, and $|V_c - V_e|$

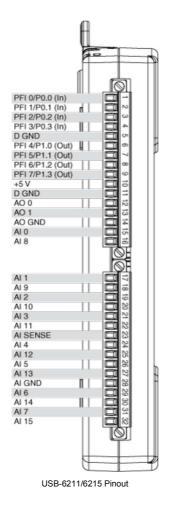
Back to Detailed Specs

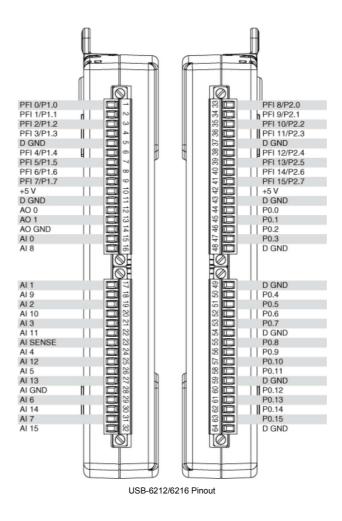
Back to Detailed Specs

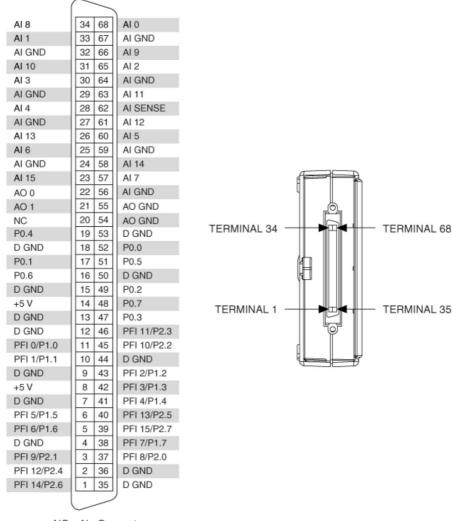
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Pinouts/Front Panel Connections



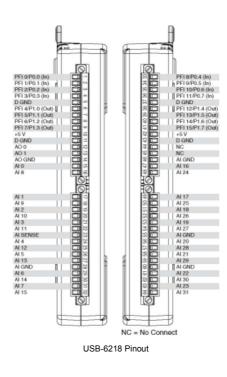






NC = No Connect

USB-6212/6216 Mass Termination Pinout



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